

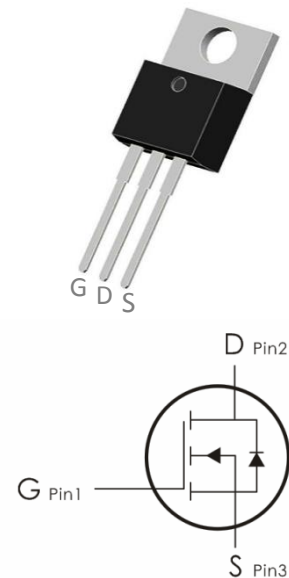
Description:

This N-Channel MOSFET uses advanced SGT technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=100V, I_D=120A, R_{DS(on)} < 6m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D^{***}	Continuous Drain Current $T_C=25^\circ C$	120	A
	Continuous Drain Current- $T_C=100^\circ C$	80	
I_{DM}^{****}	Pulsed Drain Current	350	
I_S	Continuous-Source Current	80	
P_D	Power Dissipation	150	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}^{**}$	Thermal Resistance, Junction to Case	0.85	$^\circ C/W$

$R_{\theta JA}^{**}$	Thermal Resistance, Junction to Ambient	62.5	$^{\circ}\text{C}/\text{W}$
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Electrical Characteristics: ($T_C=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Sourctce Breakdown Voltage	V _{GS} =0V, I _D =250 μ A	100	---	---	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} =0V, V _{DS} =80V	---	---	1	μ A
I _{GSS}	Gate-Source Leakage Current	V _{GS} =± 20V, V _{DS} =0A	---	---	± 30	nA
On Characteristics						
V _{GS(th)}	GATE-Source Threshold Voltage	V _{GS} =V _{DS} , I _D =250 μ A	1	---	3	V
R _{DS(ON)} ^a	Drain-Source On Resistance	V _{GS} =10V, I _D =20A	---	5	6	m Ω
		V _{GS} =4.5V, I _D =10A	---	7	8	
Dynamic Characteristics ^b						
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1MHz	---	3390	---	pF
C _{oss}	Output Capacitance		---	1940	---	
C _{rss}	Reverse Transfer Capacitance		---	210	---	
Switching Characteristics ^b						
t _{d(on)}	Turn-On Delay Time	V _{DS} =80V, I _D =20A, R _{GEN} =3.3 Ω	---	14	---	ns
t _r	Rise Time		---	58	---	ns
t _{d(off)}	Turn-Off Delay Time		---	38	---	ns
t _f	Fall Time		---	64	---	ns
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =80V, I _D =20A	---	59	---	nC
Q _{gs}	Gate-Source Charge		---	11	---	nC
Q _{gd}	Gate-Drain “Miller” Charge		---	15	---	nC
Drain-Source Diode Characteristics						

V_{SD}^a	Source-Drain Diode Forward Voltage	V _{GS} =0V, I _S =20A	---	---	1.2	V
T_{rr}	Reverse Recovery Time	I _{DS} = 20 A, V _{GS} = 0 V dI _{SD} /dt = 100 A/μs	---	61	---	nS
Q_{rr}	Reverse Recovery Charge		---	105	---	μC

Notes:

* Pulse width ≤ 300 μs, duty cycle ≤ 2 %

** Mounted on Large Heat Sink

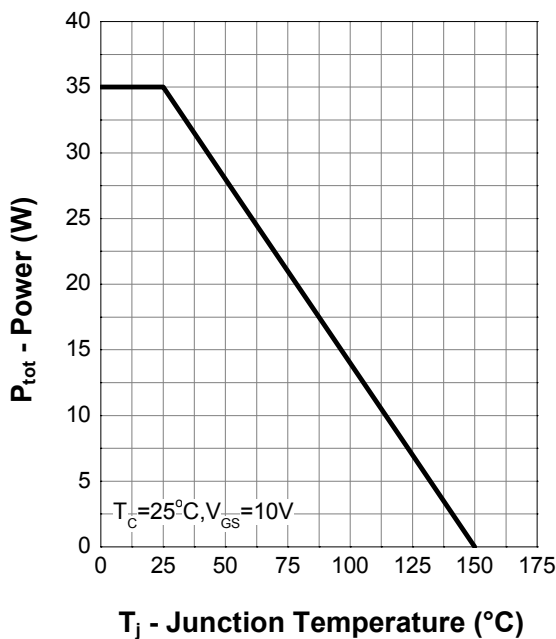
*** limited by bonding wire

a : Pulse test ; pulse width ≤ 300 μs, duty cycle ≤ 2%

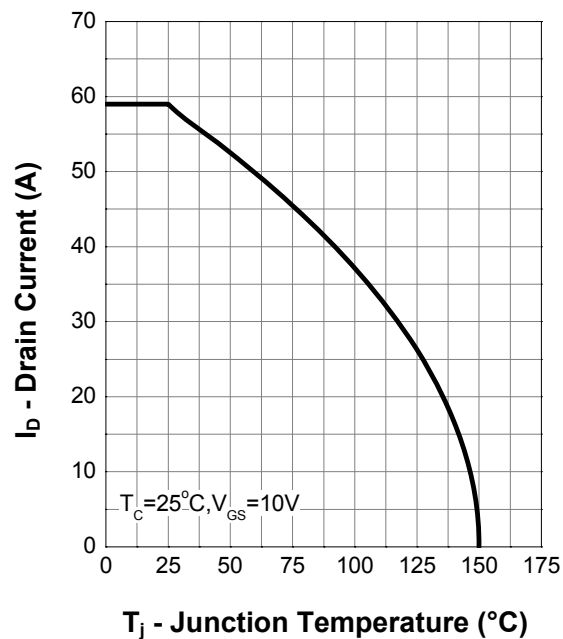
b : Guaranteed by design, not subject to production testing

Typical Characteristics: (T_C=25°C unless otherwise noted)

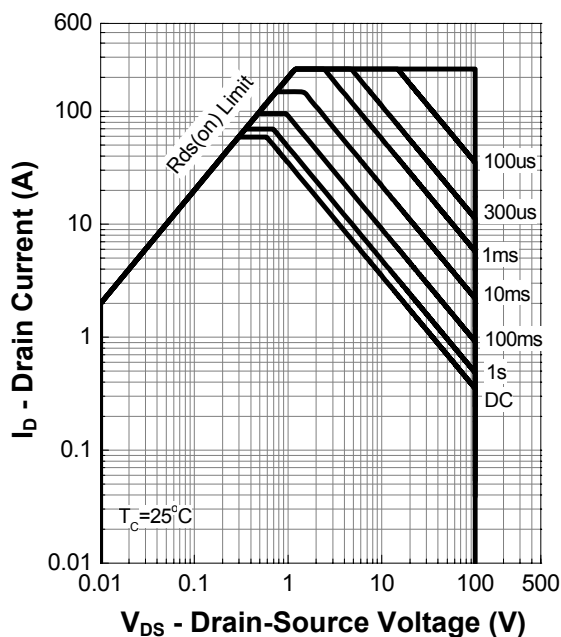
Power Capability



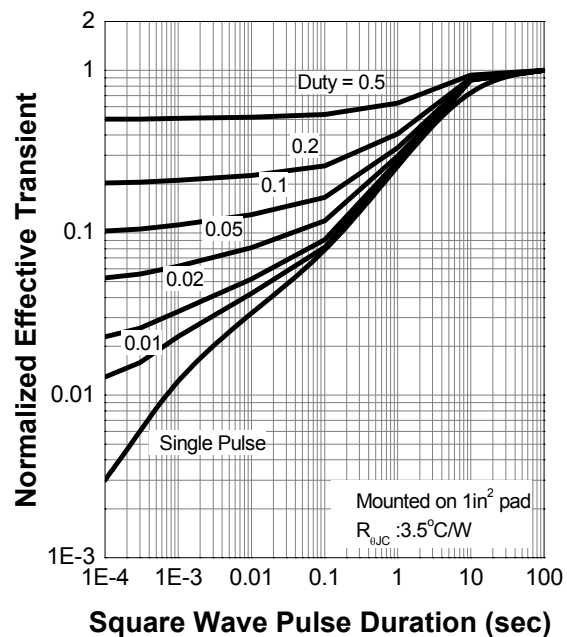
Current Capability

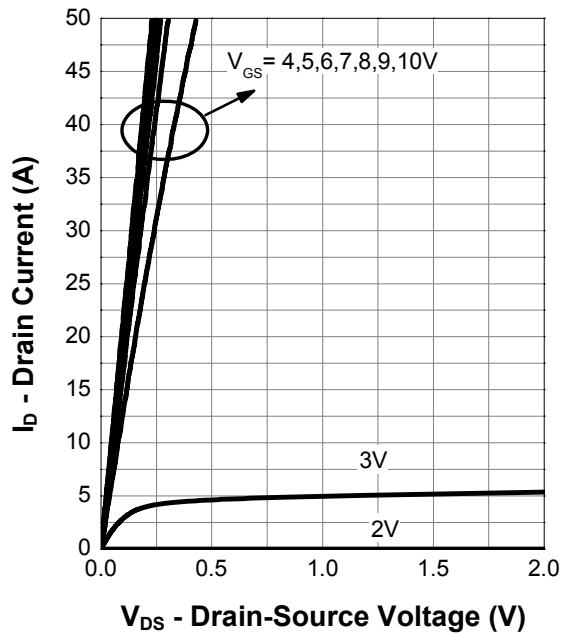
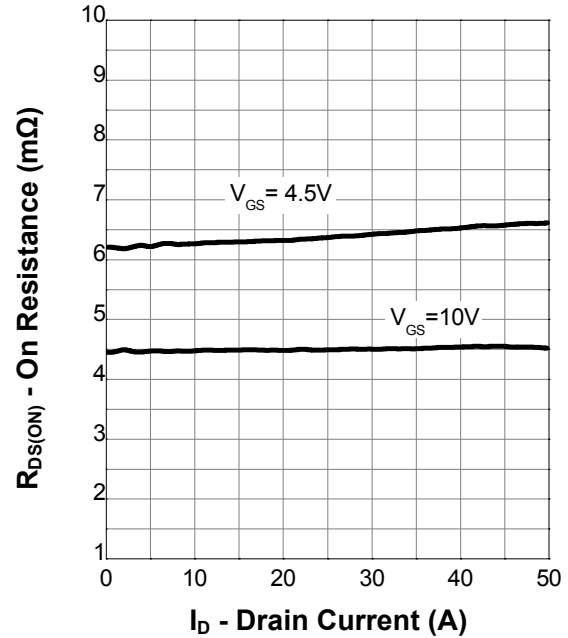
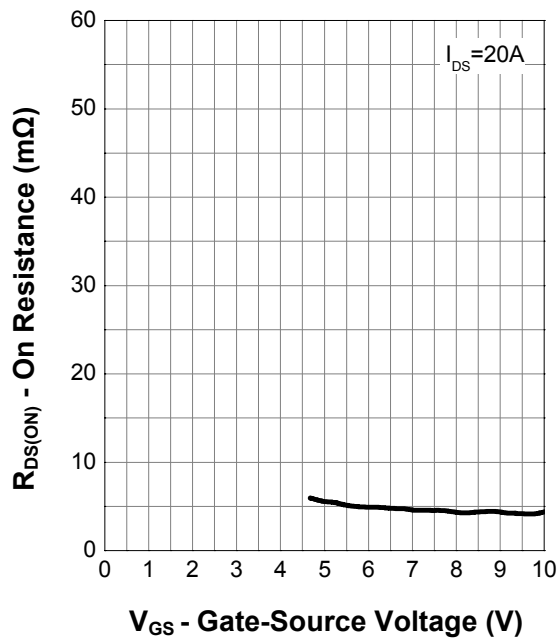
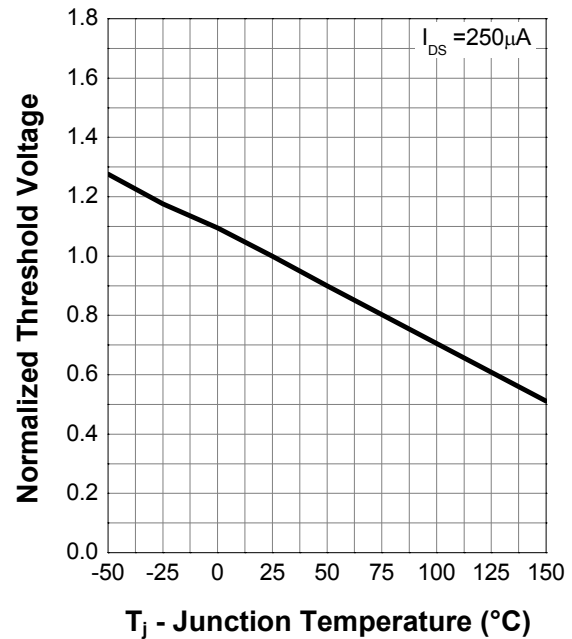


Safe Operation Area

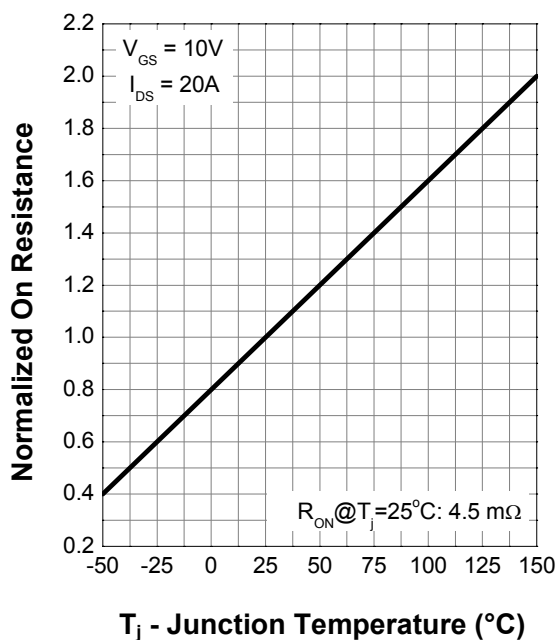


Transient Thermal Impedance

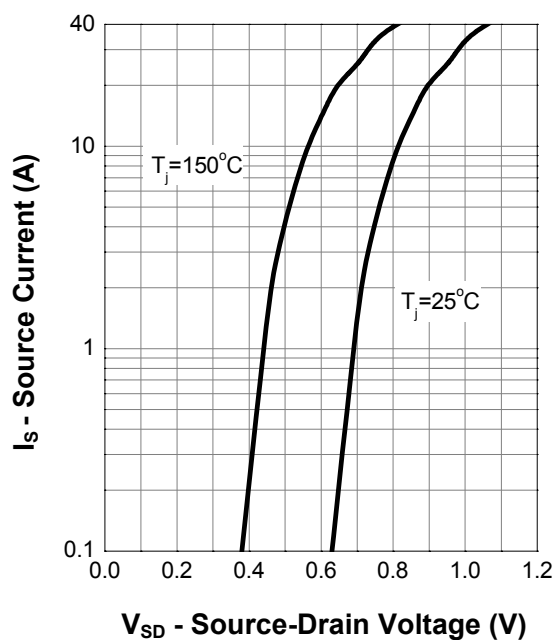


Output Characteristics

On Resistance

Transfer Characteristics

Normalized Threshold Voltage


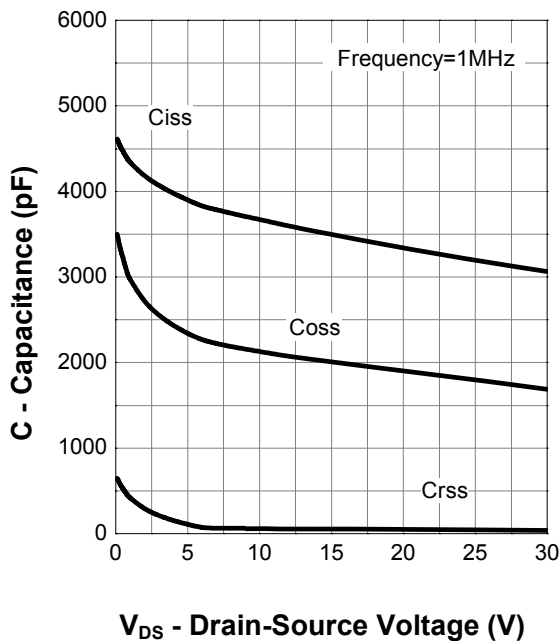
Normalized On Resistance



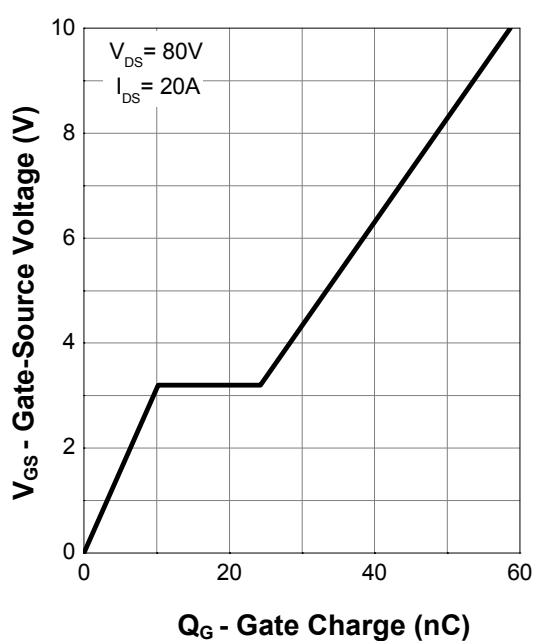
Diode Forward Current



Capacitance



Gate Charge



0086-0755-8278-9056

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